


<b>Search Notes</b>  	<b>Application/Control No.</b>  10667382	<b>Applicant(s)/Patent Under Reexamination</b>  ISHII, AKIRA
	<b>Examiner</b>  QUANG N VO	<b>Art Unit</b>  2625

SEARCHED			
Class	Subclass	Date	Examiner
358	3.06	5/27/08	QV
358	1.9	5/27/08	QV
358	533	5/27/08	QV
358	3.26	5/27/08	QV
358	536	5/27/08	QV
358	534	5/27/08	QV

SEARCH NOTES		
Search Notes	Date	Examiner
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	5/27/08	QV
Inventor Name Search, see attachment	5/27/08	QV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner